

**INFORMATION DISCLOSURE CITATION**  
*(Use several sheets if necessary)*

Docket Number (Optional) 2003US301/CIP	Application Number 10/658,840
Applicant(s) Ralph R. DAMMEL et al.	
Filing Date December 17, 2003	Group Art Unit 1756

**U.S. PATENT DOCUMENTS**

*EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
JL		6,048,661	4/11/2000	Nishi et al.			
JL		6,548,219	4/15/2003	Ito et al.			

**U.S. PATENT APPLICATION PUBLICATIONS**

*EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE

**FOREIGN PATENT DOCUMENTS**

REF	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	Transition	
						YES	NO

**OTHER DOCUMENTS**

(Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER

DATE CONSIDERED

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					Applicant(s) <b>Ralph R. DAMMEL et al.</b>		
Filing Date <b>September 9, 2003</b>					Group Art Unit <b>1756</b>		
<b>U.S. PATENT DOCUMENTS</b>							
*EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
<b>U.S. PATENT APPLICATION PUBLICATIONS</b>							
*EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
JR		2002/0061464 A1	5/23/2002	Aoal et al.			
JM		2002/0061466 A1	5/23/2002	Lee et al.			
<b>FOREIGN PATENT DOCUMENTS</b>							
	REF	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	Translation
JR		DE 2460537					YES
JM		GB 1496757					NO
<b>OTHER DOCUMENTS</b> <i>(Including Author, Title, Date, Pertinent Pages, Etc.)</i>							
JR		PCT Search Report for PCT/EP2004/001194.					
EXAMINER				DATE CONSIDERED			
<i>J. Ch</i>				<i>3/2005</i>			
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GROUP

1756

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JH	4,491,628	01/01/1985	Hiroshi Ito et al			
	5,843,624	12/01/1998	Francis M. Houlihan et al			
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	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	NO
JH	EP 1 275 666 A1	01/15/2003	Europe				
	WO 00/67072	11/09/2000	WIPO				
	WO 00/17712	03/30/2000	WIPO				
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JH		Cyclopolymerization and Polymers with Chain Ring Structures, ACS symposium Series 195 Edited by George Butler and Jim E. Kresta, Chapters 2, 3 and 4.
JH		Hoang V. Tran et al, "Metal-Catalyzed Vinyl Addition Polymers for 157 nm Resist Applications. 2. Fluorinated Norbornenes: Synthesis, Polymerization and Initial Imaging Results", Macromolecules 2002, 36, 6539-6549

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